

# Search Notes



Application/Control No.

10/736,381

Examiner

Edith M. Chang

Applicant(s)/Patent under Reexamination

DEMIR ET AL.

Art Unit

2637

## SEARCHED

Class	Subclass	Date	Examiner
375	318 261, 235 296, 326	5/10/05	ek
	330		
370	256		
455	68		
	67.11		
	232.1		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	5/10/05	ek